

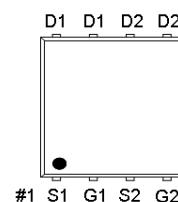
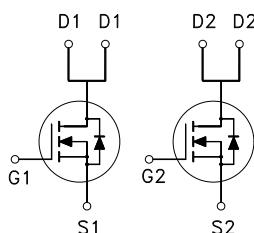
NIKO-SEM**Dual N-Channel Enhancement Mode
Field Effect Transistor****PE532DX**

PDFN 3x3P

Halogen-Free & Lead-Free

**PRODUCT SUMMARY**

| $V_{(BR)DSS}$ | $R_{DS(ON)}$ | I_D^3 |
|---------------|--------------|---------|
| 30V | 19m Ω | 21A |



G : GATE
D : DRAIN
S : SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS | SYMBOL | LIMITS | UNITS |
|--|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ³ | I_D | 21 | A |
| | | 13 | |
| | | 7.5 | |
| | | 6 | |
| | | 25 | |
| Pulsed Drain Current ¹ | I_{DM} | 17 | |
| Avalanche Current | I_{AS} | 15 | mJ |
| Avalanche Energy | E_{AS} | 14 | |
| Power Dissipation | P_D | 5 | W |
| | | 1.7 | |
| | | 1.1 | |
| Operating Junction & Storage Temperature Range | T_j, T_{stg} | -55 to 150 | °C |

THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE | SYMBOL | TYPICAL | MAXIMUM | UNITS |
|----------------------------------|-----------------|---------|---------|--------|
| Junction-to-Ambient ² | $R_{\theta JA}$ | | 70 | |
| Junction-to-Case | $R_{\theta JC}$ | | 8.5 | °C / W |

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$.

³Package limitation current is 9A.

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | LIMITS | | | UNIT |
|---|--|---|--------|------|-----------|------------------|
| | | | MIN | TYP | MAX | |
| STATIC | | | | | | |
| Drain-Source Breakdown Voltage | $V_{(\text{BR})\text{DSS}}$ | $V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$ | 30 | | | V |
| Gate Threshold Voltage | $V_{\text{GS}(\text{th})}$ | $V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$ | 1 | 1.5 | 2.5 | |
| Gate-Body Leakage | I_{GSS} | $V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{\text{DS}} = 24\text{V}, V_{\text{GS}} = 0\text{V}$ | | | 1 | |
| | | $V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 55^\circ\text{C}$ | | | 10 | μA |
| On-State Drain Current ¹ | $I_{\text{D}(\text{ON})}$ | $V_{\text{DS}} = 5\text{V}, V_{\text{GS}} = 10\text{V}$ | 25 | | | A |
| Drain-Source On-State Resistance ¹ | $R_{\text{DS}(\text{ON})}$ | $V_{\text{GS}} = 4.5\text{V}, I_D = 6.8\text{A}$ | | 19.8 | 25 | |
| | | $V_{\text{GS}} = 10\text{V}, I_D = 7.5\text{A}$ | | 16.8 | 19 | $\text{m}\Omega$ |
| Forward Transconductance ¹ | g_{fs} | $V_{\text{DS}} = 10\text{V}, I_D = 7.5\text{A}$ | | 22 | | S |
| DYNAMIC | | | | | | |
| Input Capacitance | C_{iss} | $V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 15\text{V}, f = 1\text{MHz}$ | 416 | 520 | 624 | pF |
| Output Capacitance | C_{oss} | | 42 | 70 | 105 | |
| Reverse Transfer Capacitance | C_{rss} | | 36 | 61 | 91.5 | |
| Gate Resistance | R_g | $V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$ | 0.2 | 2.4 | 4.8 | Ω |
| Total Gate Charge ² | $Q_{\text{g}(\text{VGS}=10\text{V})}$ | $V_{\text{DS}} = 15\text{V}, I_D = 7.5\text{A}$ | 11 | 14 | 16.8 | nC |
| | $Q_{\text{g}(\text{VGS}=4.5\text{V})}$ | | 6 | 7.8 | 9.4 | |
| Gate-Source Charge ² | Q_{gs} | | 1.6 | 2 | 2.4 | |
| Gate-Drain Charge ² | Q_{gd} | | 2.2 | 3.6 | 5 | |
| Turn-On Delay Time ² | $t_{\text{d}(\text{on})}$ | $V_{\text{DD}} = 15\text{V}$ $I_D \approx 7.5\text{A}, V_{\text{GEN}} = 10\text{V}, R_G = 6\Omega$ | | 14 | | nS |
| Rise Time ² | t_r | | | 10 | | |
| Turn-Off Delay Time ² | $t_{\text{d}(\text{off})}$ | | | 30 | | |
| Fall Time ² | t_f | | | 10 | | |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$) | | | | | | |
| Continuous Current ³ | I_S | | | | 21 | A |
| Forward Voltage ¹ | V_{SD} | $I_F = 7.5\text{A}, V_{\text{GS}} = 0\text{V}$ | | | 1 | V |
| Reverse Recovery Time | t_{rr} | $I_F = 7.5\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$ | | 12 | | nS |
| Reverse Recovery Charge | Q_{rr} | | | 3 | | nC |

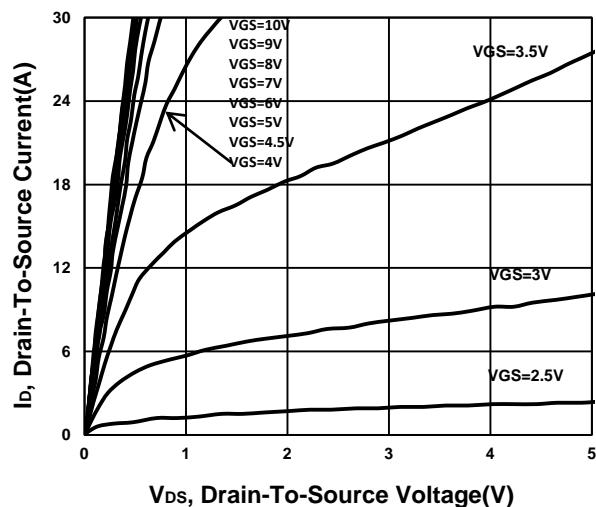
¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Package limitation current is 9A.

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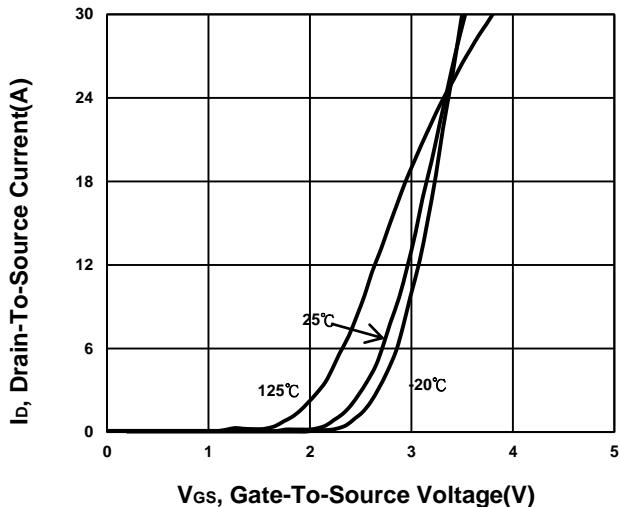
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Field Effect Transistor**

PE532DX
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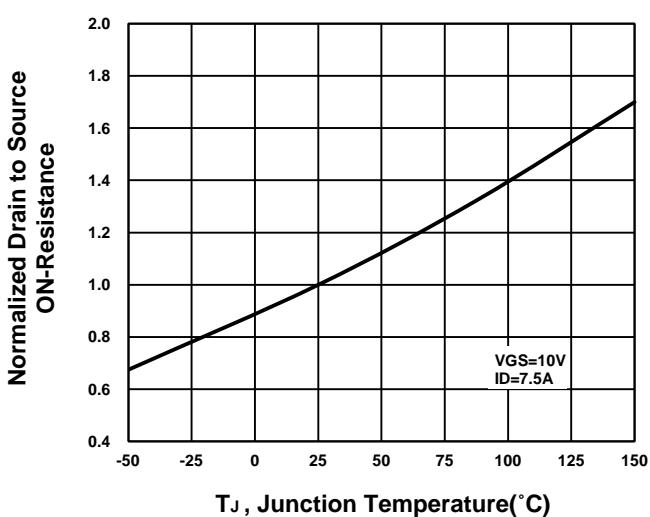
Output Characteristics



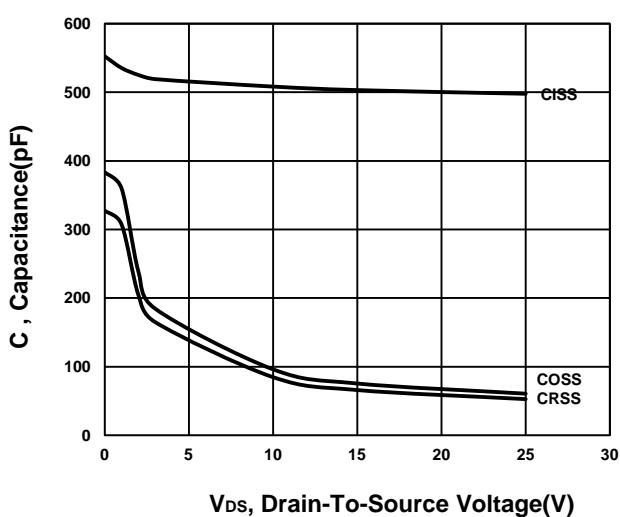
Transfer Characteristics



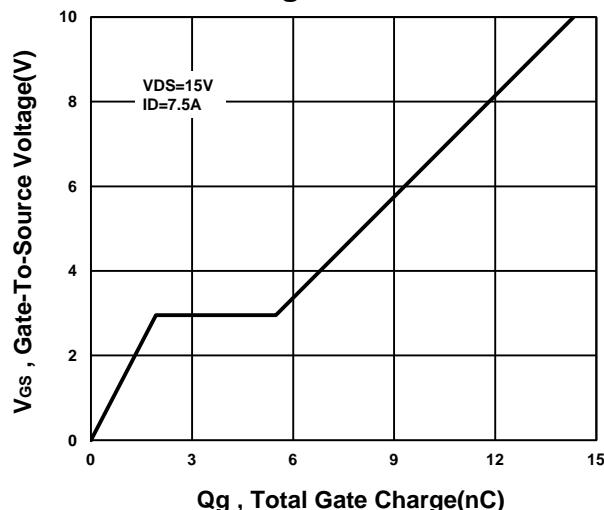
On-Resistance VS Temperature



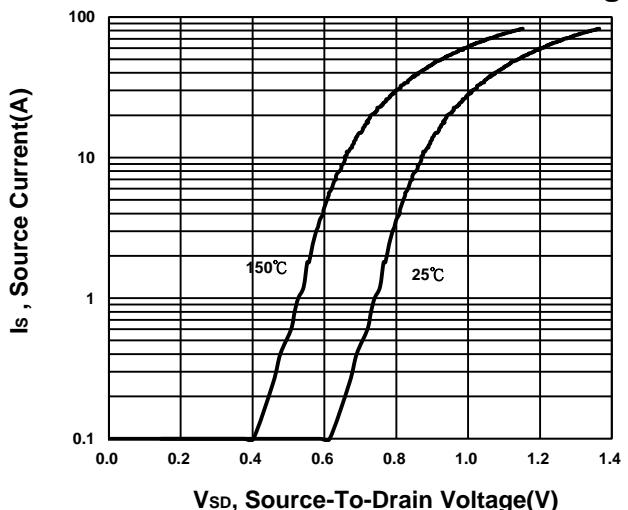
Capacitance Characteristic



Gate charge Characteristics



Source-Drain Diode Forward Voltage



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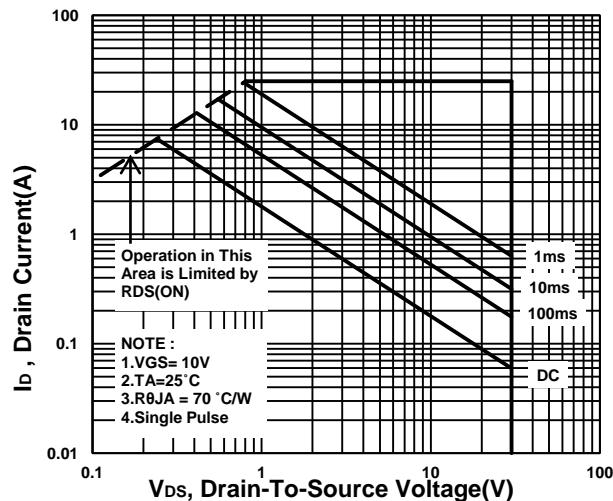
**Dual N-Channel Enhancement Mode
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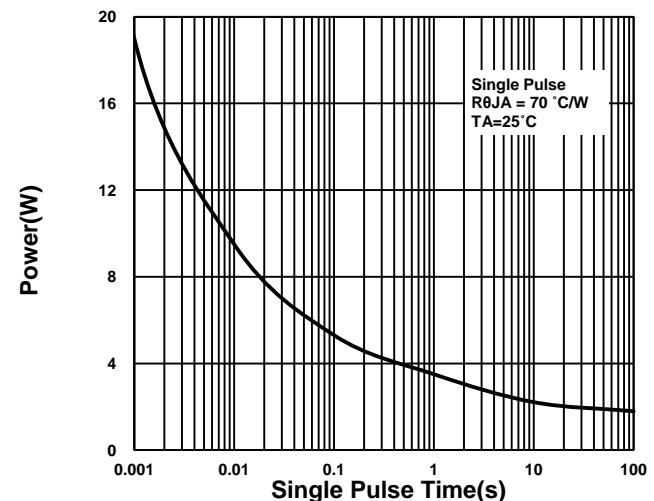
PDFN 3x3P

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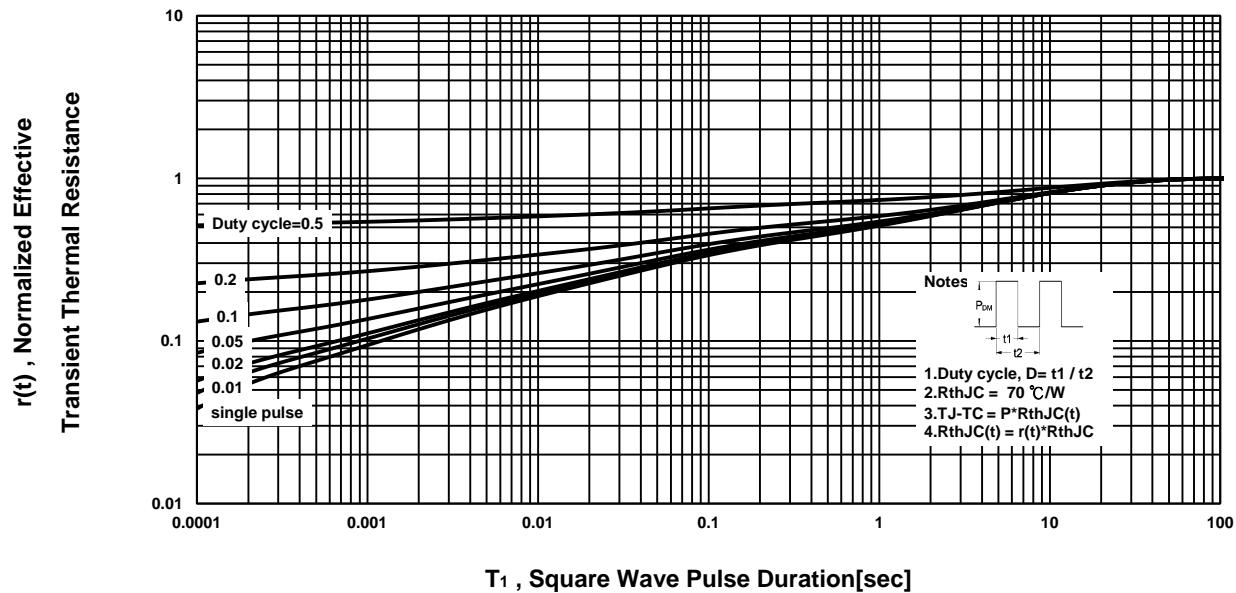
Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve



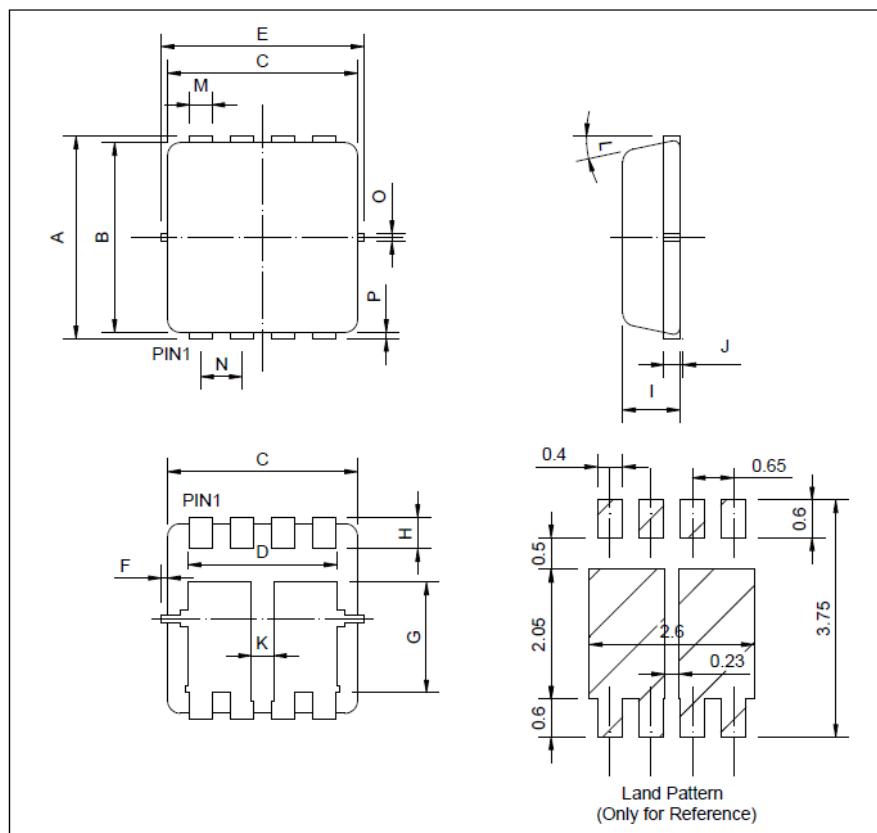
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Field Effect Transistor****PE532DX**

PDFN 3x3P

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Package Dimension**PDFN 3x3P(Dual) MECHANICAL DATA**

| Dimension | mm | | | Dimension | mm | | |
|-----------|------|------|------|-----------|------|------|------|
| | Min. | Typ. | Max. | | Min. | Typ. | Max. |
| A | 3.2 | 3.3 | 3.4 | I | 0.7 | 0.75 | 0.8 |
| B | 2.95 | 3.05 | 3.15 | J | 0.1 | 0.15 | 0.25 |
| C | 2.95 | 3.05 | 3.15 | K | 0.35 | | |
| D | | 2.29 | | L | 0° | 10° | 12° |
| E | 3.2 | 3.3 | 3.4 | M | 0.27 | 0.32 | 0.37 |
| F | | 0.13 | | N | | 0.65 | |
| G | 1.7 | 1.83 | 1.96 | O | | 0.2 | |
| H | 0.3 | 0.4 | 0.5 | P | 0.06 | 0.13 | 0.2 |



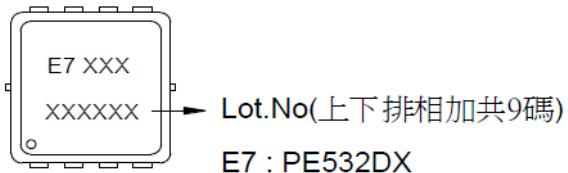
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**Dual N-Channel Enhancement Mode
Field Effect Transistor**

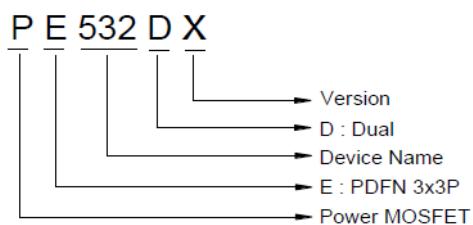
**PE532DX
PDFN 3x3P
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A. Marking Information:(Please see the corresponding data sheet)

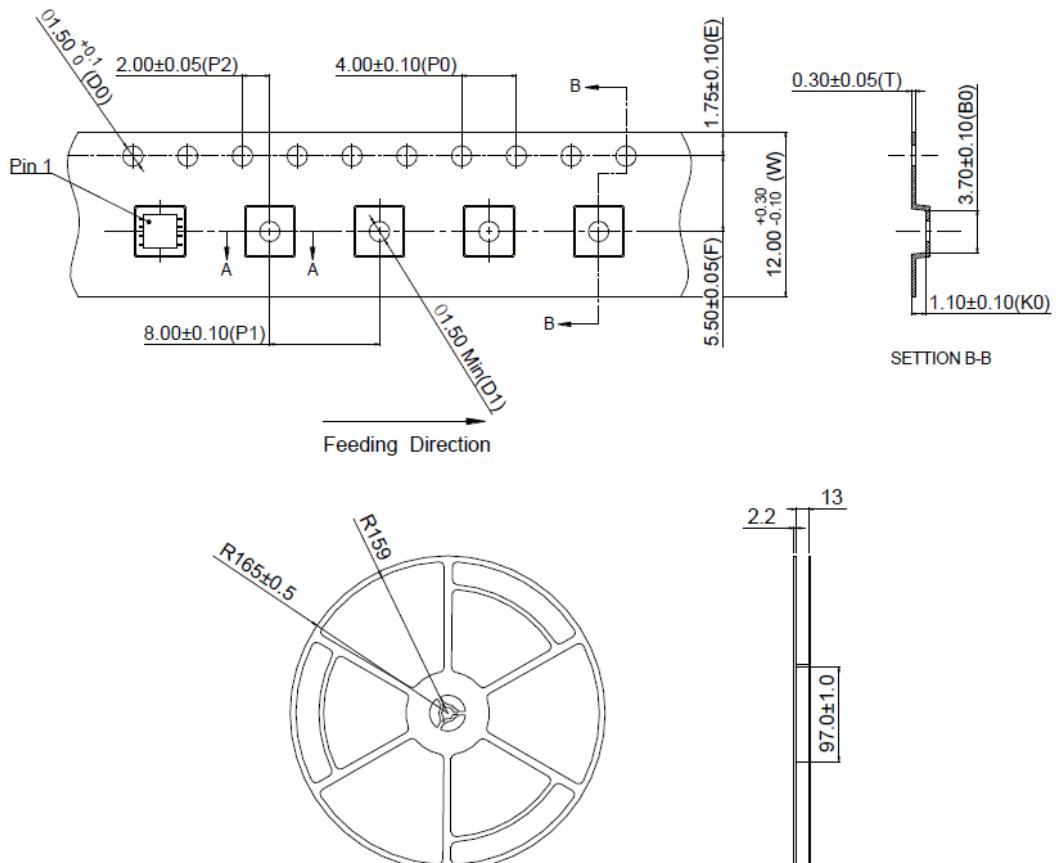
1.零件Marking 文字面說明



2.零件 Part number 說明



B. Tape&Reel Information: 5000pcs/Reel



附註:All Dimension in millimeter

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**Dual N-Channel Enhancement Mode
Field Effect Transistor**

PE532DX

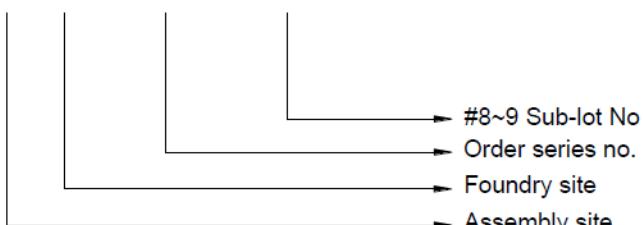
PDFN 3x3P

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C. Lot.No. & Date Code rule

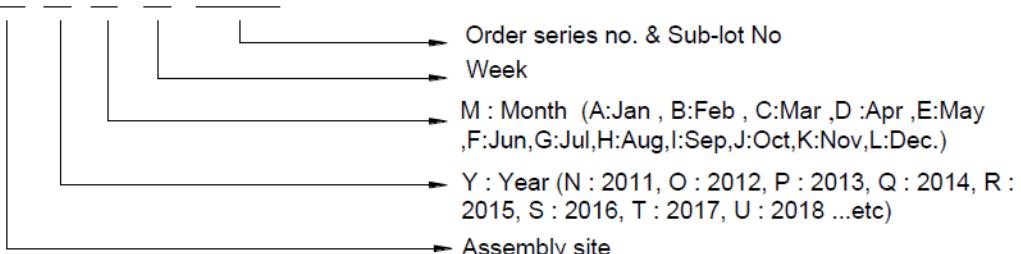
1.LOT.NO.

M N 15M21 03



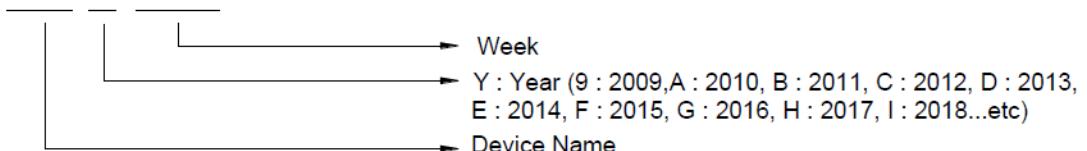
2.Date Code

D Y M X XXX



3.Date Code (for Small package)

XX Y WW



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D. Label rule

標籤內容 (Label content)



| | | | | |
|----|------------------------------|---|-------------------------------------|--|
| 1 | Label Size | 30 * 90 mm | | |
| 2 | Font style | Times New Roman or Arial (或可區分英文”O”和數字”0”，”G 和”Q”的字型即可) (Or any font capable of being distinguished for Letter O and digital 0, and for G and Q)) | | |
| 3 | NIKO-SEM | Height: 4 mm | | |
| 4 | NIKO SEMICONDUCTOR CO., LTD. | Height: 1 mm | | |
| 5 | Package | Height: 2 mm | | |
| 6 | Date | Height: 2 mm Shipping date: YYYY/MM/DD, ex. 2008/09/12 | | |
| 7 | Device | Height: 3 mm (Max: 16 Digit) Device Name not including Rev. | | |
| 8 | Lot | Height: 3 mm (Max: 9 Digit) Sub lot | | |
| 9 | D/C | Height: 3 mm (Max: 7 Digit) | | |
| 10 | QTY | Height: 3 mm (Max: 6 Digit) Thousand mark is no needed | | |
| 11 | Pb Free label | | Diameter: 1 cm Font color: Black | bottom color: Green Font style: Arial |
| 12 | Halogen Free label | | Diameter: 1 cm Font color: Black | bottom color: Green Font style: Arial |
| 13 | Scan info | Device / Lot / D/C / QTY , Insert “ / ” between every parts. for example: P3055LDG/G12345601/GGG2301/2000 DPI (Dots per inch): Over 300 dpi Code : Code 128 Height: 6 mm at least | | |